

<b>Notice of References Cited</b>	Application/Control No. 10/564,303		Applicant(s)/Patent Under Reexamination UCHIYAMA ET AL.	
	Examiner Renee Danega		Art Unit 3736	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,395,366	03-1995	D'Andrea et al.	604/890.1
*	B	US-2002/0111544	08-2002	Iddan, Gavriel J.	600/310
*	C	US-2001/0051766	12-2001	Gazdzinski, Robert F.	600/309
*	D	US-6,240,312	05-2001	Alfano et al.	600/476
*	E	US-7,063,671	06-2006	Couvillon, Jr., Lucien Alfred	600/562
*	F	US-2002/0132226	09-2002	Nair et al.	435/4
*	G	US-5,279,607	01-1994	Schentag et al.	604/890.1
*	H	US-2002/0042562	04-2002	Meron et al.	600/361
*	I	US-7,378,056	05-2008	Black, Robert D.	422/82.05
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.